

Figure 3.15 "Newton's rings" interference fringes are produced when two plano-convex lenses are placed together with their plane surfaces in contact. The rings are created by interference between the light reflected off the two surfaces as a result of a slight gap between them, indicating that these surfaces are not precisely plane but are slightly convex. (credit: Ulf Seifert)

Thin-film interference has many other applications, both in nature and in manufacturing. The wings of certain moths and butterflies have nearly iridescent colors due to thin-film interference. In addition to pigmentation, the wing's color is affected greatly by constructive interference of certain wavelengths reflected from its film-coated surface. Some car manufacturers offer special paint jobs that use thin-film interference to produce colors that change with angle. This expensive option is based on variation of thin-film path length differences with angle. Security features on credit cards, banknotes, driving licenses, and similar items prone to forgery use thin-film interference, diffraction gratings, or holograms. As early as 1998, Australia led the way with dollar bills printed on polymer with a diffraction grating security feature, making the currency difficult to forge. Other countries, such as Canada, New Zealand, and Taiwan, are using similar technologies, while US currency includes a thin-film interference effect.

3.5 The Michelson Interferometer

Learning Objectives

By the end of this section, you will be able to:

- Explain changes in fringes observed with a Michelson interferometer caused by mirror movements
- Explain changes in fringes observed with a Michelson interferometer caused by changes in medium

The Michelson **interferometer** (invented by the American physicist Albert A. Michelson, 1852–1931) is a precision instrument that produces interference fringes by splitting a light beam into two parts and then recombining them after they have traveled different optical paths. **Figure 3.16** depicts the interferometer and the path of a light beam from a single point on the extended source S, which is a ground-glass plate that diffuses the light from a monochromatic lamp of wavelength λ_0 . The beam strikes the half-silvered mirror M, where half of it is reflected to the side and half passes through the mirror.

The reflected light travels to the movable plane mirror M_1 , where it is reflected back through M to the observer. The transmitted half of the original beam is reflected back by the stationary mirror M_2 and then toward the observer by M.

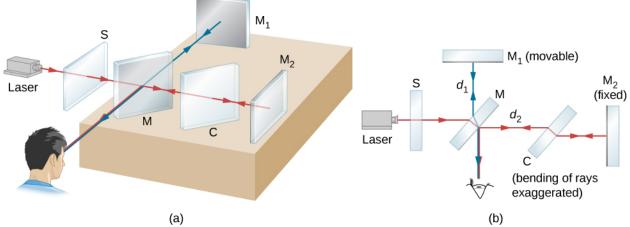


Figure 3.16 (a) The Michelson interferometer. The extended light source is a ground-glass plate that diffuses the light from a laser. (b) A planar view of the interferometer.

Because both beams originate from the same point on the source, they are coherent and therefore interfere. Notice from the figure that one beam passes through M three times and the other only once. To ensure that both beams traverse the same thickness of glass, a compensator plate C of transparent glass is placed in the arm containing M_2 . This plate is a duplicate

of M (without the silvering) and is usually cut from the same piece of glass used to produce M. With the compensator in place, any phase difference between the two beams is due solely to the difference in the distances they travel.

The path difference of the two beams when they recombine is $2d_1 - 2d_2$, where d_1 is the distance between M and M_1 , and d_2 is the distance between M and M_2 . Suppose this path difference is an integer number of wavelengths $m\lambda_0$. Then, constructive interference occurs and a bright image of the point on the source is seen at the observer. Now the light from any other point on the source whose two beams have this same path difference also undergoes constructive interference and produces a bright image. The collection of these point images is a bright fringe corresponding to a path difference of $m\lambda_0$

(**Figure 3.17**). When M₁ is moved a distance $\Delta d = \lambda_0/2$, this path difference changes by λ_0 , and each fringe moves to

the position previously occupied by an adjacent fringe. Consequently, by counting the number of fringes *m* passing a given point as M_1 is moved, an observer can measure minute displacements that are accurate to a fraction of a wavelength, as shown by the relation

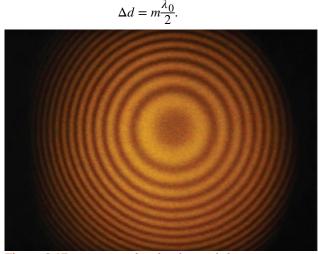


Figure 3.17 Fringes produced with a Michelson interferometer. (credit: "SILLAGESvideos"/YouTube)

Example 3.5

Precise Distance Measurements by Michelson Interferometer

A red laser light of wavelength 630 nm is used in a Michelson interferometer. While keeping the mirror M_1 fixed, mirror M_2 is moved. The fringes are found to move past a fixed cross-hair in the viewer. Find the distance the mirror M_2 is moved for a single fringe to move past the reference line.

Strategy

Refer to **Figure 3.16** for the geometry. We use the result of the Michelson interferometer interference condition to find the distance moved, Δd .

Solution

For a 630-nm red laser light, and for each fringe crossing (m = 1), the distance traveled by M_2 if you keep M_1 fixed is

$$\Delta d = m \frac{\lambda_0}{2} = 1 \times \frac{630 \text{ nm}}{2} = 315 \text{ nm} = 0.315 \,\mu\text{m}.$$

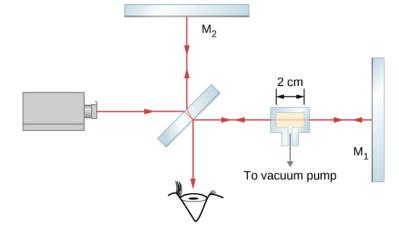
Significance

An important application of this measurement is the definition of the standard meter. As mentioned in **Units and Measurement (http://cnx.org/content/m58268/latest/)**, the length of the standard meter was once defined as the mirror displacement in a Michelson interferometer corresponding to 1,650,763.73 wavelengths of the particular fringe of krypton-86 in a gas discharge tube.

Example 3.6

Measuring the Refractive Index of a Gas

In one arm of a Michelson interferometer, a glass chamber is placed with attachments for evacuating the inside and putting gases in it. The space inside the container is 2 cm wide. Initially, the container is empty. As gas is slowly let into the chamber, you observe that dark fringes move past a reference line in the field of observation. By the time the chamber is filled to the desired pressure, you have counted 122 fringes move past the reference line. The wavelength of the light used is 632.8 nm. What is the refractive index of this gas?



Strategy

The m = 122 fringes observed compose the difference between the number of wavelengths that fit within the empty chamber (vacuum) and the number of wavelengths that fit within the same chamber when it is gas-filled. The wavelength in the filled chamber is shorter by a factor of *n*, the index of refraction.

Solution

The ray travels a distance t = 2 cm to the right through the glass chamber and another distance t to the left upon reflection. The total travel is L = 2t. When empty, the number of wavelengths that fit in this chamber is

$$N_0 = \frac{L}{\lambda_0} = \frac{2t}{\lambda_0}$$

where $\lambda_0 = 632.8 \text{ nm}$ is the wavelength in vacuum of the light used. In any other medium, the wavelength is $\lambda = \lambda_0 / n$ and the number of wavelengths that fit in the gas-filled chamber is

$$N = \frac{L}{\lambda} = \frac{2t}{\lambda_0/n}.$$

The number of fringes observed in the transition is

$$= N - N_0,$$

$$= \frac{2t}{\lambda_0/n} - \frac{2t}{\lambda_0}$$

$$= \frac{2t}{\lambda_0}(n-1).$$

m

Solving for (n-1) gives

$$n-1 = m \left(\frac{\lambda_0}{2t}\right) = 122 \left(\frac{632.8 \times 10^{-9} \text{ m}}{2(2 \times 10^{-2} \text{ m})}\right) = 0.0019$$

and n = 1.0019.

Significance

The indices of refraction for gases are so close to that of vacuum, that we normally consider them equal to 1. The difference between 1 and 1.0019 is so small that measuring it requires a correspondingly sensitive technique such as interferometry. We cannot, for example, hope to measure this value using techniques based simply on Snell's law.



3.3 Check Your Understanding Although *m*, the number of fringes observed, is an integer, which is often regarded as having zero uncertainty, in practical terms, it is all too easy to lose track when counting fringes. In **Example 3.6**, if you estimate that you might have missed as many as five fringes when you reported m = 122 fringes, (a) is the value for the index of refraction worked out in **Example 3.6** too large or too small? (b) By how much?

Problem-Solving Strategy: Wave Optics

Step 1. *Examine the situation to determine that interference is involved.* Identify whether slits, thin films, or interferometers are considered in the problem.

Step 2. *If slits are involved*, note that diffraction gratings and double slits produce very similar interference patterns, but that gratings have narrower (sharper) maxima. Single-slit patterns are characterized by a large central maximum and smaller maxima to the sides.

Step 3. *If thin-film interference or an interferometer is involved, take note of the path length difference between the two rays that interfere.* Be certain to use the wavelength in the medium involved, since it differs from the wavelength in vacuum. Note also that there is an additional $\lambda/2$ phase shift when light reflects from a medium with a greater index of refraction.

Step 4. *Identify exactly what needs to be determined in the problem (identify the unknowns).* A written list is useful. Draw a diagram of the situation. Labeling the diagram is useful.

Step 5. Make a list of what is given or can be inferred from the problem as stated (identify the knowns).

Step 6. *Solve the appropriate equation for the quantity to be determined (the unknown) and enter the knowns.* Slits, gratings, and the Rayleigh limit involve equations.

Step 7. For thin-film interference, you have constructive interference for a total shift that is an integral number of wavelengths. You have destructive interference for a total shift of a half-integral number of wavelengths. Always keep in mind that crest to crest is constructive whereas crest to trough is destructive.

Step 8. *Check to see if the answer is reasonable: Does it make sense?* Angles in interference patterns cannot be greater than 90° , for example.